# **CMOS Dual Precision Monostable Multivibrator**

High-Voltage Types (20-Volt Rating)

#### Features:

- Retriggerable/resettable capability
- Trigger and reset propagation delays independent of R<sub>x</sub>, C<sub>x</sub>
- Triggering from leading or trailing edge
- Q and Q buffered outputs available
- Separate resets
- Replaces CD4538B Type

■ CD14538B dual precision monostable multivibrator provides stable retriggerable/resettable one-shot operation for any fixed-voltage timing application.

An external resistor  $(R_X)$  and an external capacitor  $(C_X)$  control the timing and accuracy for the circuit. Adjustment of  $R_X$  and  $C_X$  provides a wide range of output pulse widths from the Q and  $\overline{Q}$  terminals. The time delay from trigger input to output transition (trigger propagation delay) and the time delay from reset input to output transition (reset propagation delay) are independent of  $R_X$  and  $C_X$ . Precision control of output pulse widths is achieved through linear CMOS techniques.

Leading-edge-triggering (+TR) and trailing-edge-triggering (-TR) inputs are provided for triggering from either edge of an input pulse. An unused +TR input should be tied to  $V_{SS}$ . An unused -TR input should be tied to  $V_{DD}$ . A RESET (on low level) is provided for immediate termination of the output pulse or to prevent output pulses when power is turned on. An unused RESET input should be tied to  $V_{DD}$ . However, if an entire section of the CD14538B is not used, its inputs must be tied to either  $V_{DD}$  or  $V_{SS}$ . See Table I.

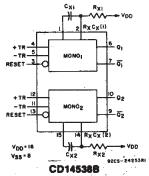
In normal operation the circuit retriggers (extends the output pulse one period) on the application of each new trigger pulse. For operation in the non-retriggerable mode,  $\overline{Q}$  is connected to -TR when leading-edge triggering (+TR) is used or  $\overline{Q}$  is connected to +TR when trailing-edge triggering (-TR) is used. The time period (T) for this multivibrator can be calculated by:  $T = R_X C_X$ .

The minimum value of external resistance,  $R_x$ , is 4 K $\Omega$ . The minimum and maximum values of external capacitance,  $C_x$ , are 0 pF and 100  $\mu$ F, respectively.

The CD14538B is interchangeable with type MC14538 and is similar to and pin-compatible with the CD4098B\* and CD4538B. It can replace the CD4538B which type is not recommended for new designs.

The CD14538B types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).





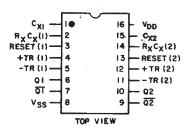
- **FUNCTIONAL DIAGRAM** 
  - Wide range of output-pulse widths
  - Schmitt-trigger input allows unlimited rise and fall times on +TR and -TR inputs
  - 100% tested for maximum quiescent current at 20 V
  - Maximum input current of 1 µA at 18 V over full package-temperature range; 100 nA at 18 V and 25° C
  - Noise margin (full package-temperature range):

1 V at 
$$V_{DD} = 5 V$$
  
2 V at  $V_{DD} = 10 V$ 

- $2.5 \ V \ at \ V_{DD} = 15 \ V$
- 5-V, 10-V, and 15-V parametric ratings
- Standardized, symmetrical output characteristics
- Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices."

#### **Applications:**

- Pulse delay and timing
- Pulse shaping



TERMINALS 1,8,15 ARE ELECTRICALLY CONNECTED INTERNALLY 92CS-24848RI

**Terminal Assignment** 

#### MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE RANGE, (V <sub>DD</sub> )	
Voltages referenced to VSS Terminal)	0.5V to +20V
INPUT VOLTAGE RANGE, ALL INPUTS	0.5V to Vnn +0.5V
DC INPUT CURRENT, ANY ONE INPUT	+10mA
POWER DISSIPATION PER PACKAGE (PD):  For TA = -55°C to +100°C  For TA = +100°C to +125°C  Page 1 inceptible	
For T <sub>A</sub> = -55°C to +100°C	500mW
For TA = +100°C to +125°C	at 12mW/°C to 200mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR	As the second second
FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)	100mW
FOR T <sub>A</sub> = FULL PACKAGE-TEMPERATURE RANGE (All Package Types)	100mW
OPERATING-TEMPERATURE RANGE (T <sub>A</sub> )	55°C to +125°C
FOR T <sub>A</sub> = FULL PACKAGE-TEMPERATURE RANGE (All Package Types).  OPERATING-TEMPERATURE RANGE (T <sub>A</sub> )  STORAGE TEMPERATURE RANGE (T <sub>Stg</sub> )  LEAD TEMPERATURE (DURING SOLDERING):  At distance 1/16 ± 1/32 inch (1.59 ± 0.79mm) from case for 10s max	

#### RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operating is always within the following ranges:

CHARACTERISTIC	V <sub>DO</sub>	LIM	UNITS	
CHARACTERISTIC	 (V)	Min.	Max.	UNIIS
Supply-Voltage Range (For T <sub>A</sub> =Full Package-Temperature Range)		3	18	y
Input Pulse Width twh, twL	 5	140		,
+TR, -TR, or RESET	 10	80	_	ns
	15	60		

# TABLE I CD4538B FUNCTIONAL TERMINAL CONNECTIONS

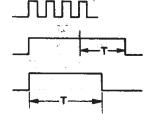
FUNCTIION	V <sub>DD</sub>	TO M. NO.	1	TO II. NO.	1	PULSE RM. NO.	OTHER CONNECTIONS	
	MONO1	MONO <sub>2</sub>	MONO <sub>1</sub>	MONO <sub>2</sub>	MONO <sub>1</sub>	MONO <sub>2</sub>	MONO:	MONO <sub>2</sub>
Leading-Edge Trigger/ Retriggerable	3, 5	11, 13			4	12		
Leading-Edge Trigger/ Non-Retriggerable	3	13		: 	4	12	5-7	11-9
Trailing-Edge Trigger/ Retriggerable	3	. 13	4	12	5	11		
Trailing-Edge Trigger/ Non-Retriggerable	3	13	ž		5	11	4-6	12-10

#### NOTES:

- 1. A RETRIGGERABLE ONE-SHOT MULTIVIBRATOR HAS AN OUTPUT PULSE WIDTH WHICH IS EXTENDED ONE FULL TIME PERIOD (T) AFTER APPLICATION OF THE LAST TRIGGER PULSE.
- 2. A NON—RETRIGGERABLE ONE-SHOT MULTIVIBRATOR HAS A TIME PERIOD (T) REFERENCED FROM THE APPLICATION OF THE FIRST TRIGGER PULSE.

INPUT PULSE TRAIN

RETRIGGERABLE MODE PULSE WIDTH (+TR MODE) NON-RETRIGGERABLE MODE PULSE WIDTH



(+TR MODE)

#### **STATIC ELECTRICAL CHARACTERISTICS**

CHARACTERISTIC	CO	NDITIO	NS	LIN	LIMITS AT INDICATED TEMPERATURES (°C)							
	Vo	V <sub>IN</sub>	V <sub>DD</sub>		40			<b></b>	+25		1	
<del>_</del>	(V)	(V)	(V)	-55	-40	+85	+125	Min.	Тур.	Max.	ļ	
Quiescent Device Current, I <sub>OD</sub> Max.		0,5	5	5	5	150	150		0.04	5	1	
		0,10	10	10	10	300	300		0.04	10	μA	
	<u> </u>	0,15	15	20	20	600	600		0.04		20	
		0,20	20	100	100	3000	3000		0.08	100		
Output Low (Sink)	0.4	0,5	5 .	0.64	0.61	0.42	0.36	0.51	. 1		<del>-</del>	
Current, IoL Min.	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6			
	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8		1	
Output High (Source) Current, I <sub>OH</sub> Min.	4.6	0,5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	_	mA	
	2.5	0,5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2			
	9.5	0,10	_10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	_	_	
	13.5	0,15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	_	]	
Output Voltage:		0,5	5		0.	05			0	0.05	T	
Low-Level, Vol. Max.		0,10	10		0.	05			0	0.05	1	
LOW-Level, VOL MAX.	_	0,15	15		0.	05		_	0	0.05	1	
Output Voltage:	_	0,5	5		4.	95		4.95	5	_	1	
High-Level, Von Min.	_	0,10	10		9.	95		9.95	10	_	V	
riigii-Level, von Mill.	_	0,15	15		14	.95		14.95	15		1	
Input Low Voltage,	0.5,4.5	_	5		1.	.5		_	_	1.5		
Vil Max.	1,9		10			3		_		3	1	
VIL MAX.	1.5,13.5	_	. 15			1		-	_	4	1	
Input High Voltage,	0.5,4.5		5	1	3.	.5		3.5			\	
	1,9		10			7		7		_	1	
/ <sub>Iн</sub> Min.	1.5,13.5	_	15		1	1		11	_		1	
Input Current, I <sub>IN</sub> Max.		0,18	18	±0.1	±0.1	±1	±1	_	±10 <sup>-5</sup>	±0.1	μА	

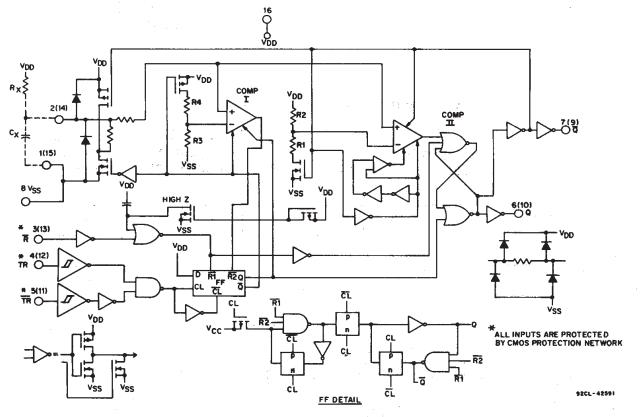


Fig. 1 - Logic diagram (½ of device shown).

#### DYNAMIC ELECTRICAL CHARACTERISTICS, At $T_A=25^{\circ}$ C; Input $t_r,t_r=20$ ns, $C_L=50$ pF

CHARACTERISTIC		TEST CONDITIONS		LIMITS		
CHARACTERISTIC		V <sub>DD</sub> (V)	Min.	Тур.	Max.	UNITS
Transition Time t <sub>T</sub>	iн, tтнь	5	_	100	200	
		10	_	50	100	
		15		40	80	
Propagation Delay Time: t	PLH, TPHL	5	_	300	600	1
+TR or -TR to Q or Q		10	l –	150	300	
		15	L –	100	220	ns
Reset to Q or Q		5		250	500	1
		10		125	250	
		15		95	190	
Minimum Input Pulse Width:	t <sub>WH</sub> , t <sub>WL</sub>	5	_	80	140	1
+TR, -TR or Reset		10	-	40	80	1
		15	_	30	60	
Output Pulse Width - Q or Q:	T	5	198	210	230	
$C_X = 0.002 \mu\text{F},  R_X = 100 \text{K}\Omega$		10	200	212	232	μs
		15	202	214	234	
C <sub>x</sub> =0.1 μF, R <sub>x</sub> =100 KΩ		5	9.4	9.97	10.5	
	:	10	9.4	9.95	10.6	ms
		15	9.5	10	10.6	i
C <sub>x</sub> =10 μF, R <sub>x</sub> =100 KΩ		5	0.95	1	1.06	
		10	0.95	1	1.06	s
		15	0.96	1.01	1.07	
Pulse Width Match between 10	00 (T <sub>1</sub> -T <sub>2</sub> )	5	_	±1		
circuits in same package:	T	10	_	±1	_	%
$C_x=0.1 \mu F$ , $R_x=100 K\Omega$	T <sub>1</sub>	15	_	±1	_	
Minimum Retrigger Time	ter	5	0	. —	_	
		10	0	-	_	ns
		15	0		_	
Input Capacitance	Cin	Any Input	_	5	7.5	pF

<sup>\*</sup>Note: Minimum  $R_x$  value=4  $K\Omega$ , minimum  $C_x$  value=5000 pF.

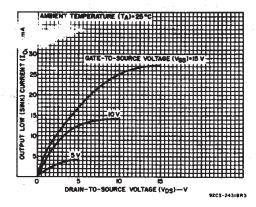


Fig. 2 - Typical output low (sink) current characteristics.

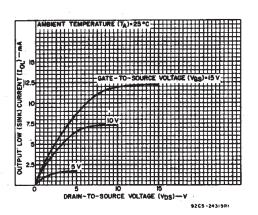


Fig. 3 - Minimum output low (sink) current characteristics.

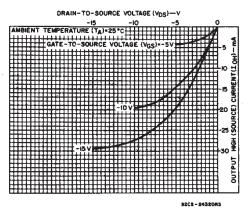


Fig. 4 - Typical output high (source) current characteristics.

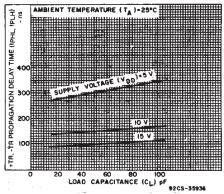


Fig. 6 - Typical propagation delay time as a function of load capacitance (+TR or -TR to Q or  $\overline{Q}$ ).

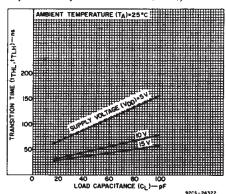


Fig. 8 - Typical transition time as a function of load capacitance.

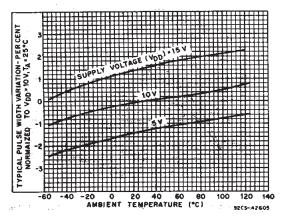


Fig. 10 - Typical pulse-width variation as a function of temperature ( $R_x$ =100 K $\Omega$ ,  $C_x$ =0.1  $\mu F$ ).

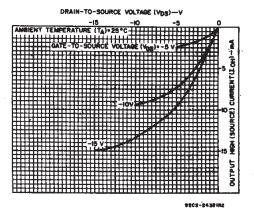


Fig. 5 - Minimum output high (source) current characteristics.

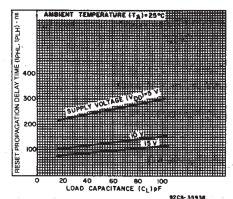


Fig. 7 - Typical propagation delay time as a function of load capacitance (RESET to Q or Q).

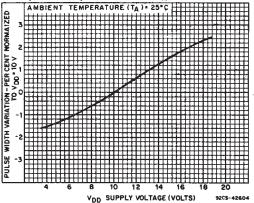


Fig. 9 - Typical pulse-width variation as a function of supply voltage.

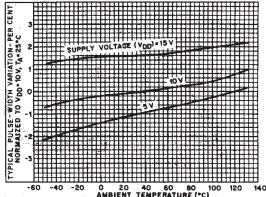


Fig. 11 - Typical pulse-width variation as a function of temperature ( $R_X=100 \text{ K}\Omega$ ,  $C_X=2000 \text{ pF}$ ).

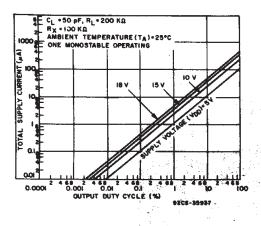


Fig. 12 - Typical total supply current as a function of output duty cycle.

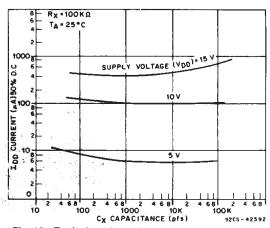
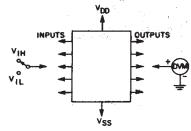


Fig. 13 - Typical total supply current as a function of load capacitance.



92CS-27441RI

NOTE:

- 1. Test any combination of inputs.
- 2. When measuring  $V_{\text{IM}}$  or  $V_{\text{IL}}$  for Schmitt trigger inputs (+TR, -TR), the input must first be brought to  $V_{\text{DD}}$  or  $V_{\text{SS}}$ , respectively, then reduced to the specified limit.

Fig. 14 - Input voltage test circuit.

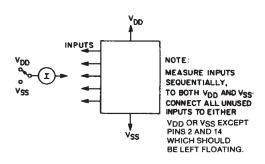


Fig. 15 - Input leakage-current test circuit.

# VDO INPUTS VSS VSS

Fig. 16 - Quiescent device current test circuit.

#### Power-Down Mode

During a rapid power-down condition, as would occur with a power-supply short circuit or with a poorly filtered power supply, the energy stored in  $C_X$  could discharge into Pin 2 or 14. To avoid possible device damage in this mode, when  $C_X$  is  $\geq 0.5$  microfarad, a protection diode with a 1-ampere or higher rating (1N5395 or equivalent) and a separate ground return for  $C_X$  should be provided as shown in Fig. 17.

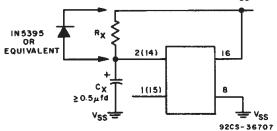


Fig. 17 - Rapid power-down protection circuit.

An alternate protection method is shown in Fig. 18, where a 51-ohm current-limiting resistor is inserted in series with  $C_x$ . Note that a small pulse width decrease will occur however, and  $R_x$  must be appropriately increased to obtain the originally desired pulse width.

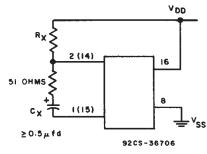
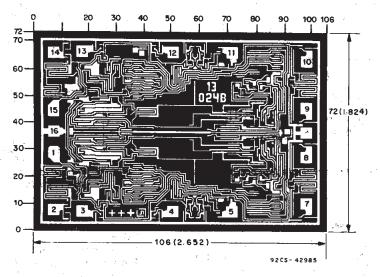


Fig. 18 - Alternate rapid power-down protection circuit.



Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils  $(10^{-3} inch)$ .

Dimensions and pad layout for CD145388H.

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#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	<b>Device Marking</b> (4/5)	Samples
5962-9055701EA	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9055701EA CD14538BF3A	Samples
CD14538BE	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD14538BE	Samples
CD14538BF	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD14538BF	Samples
CD14538BF3A	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9055701EA CD14538BF3A	Samples
CD14538BM96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD14538BM	Samples
CD14538BNSR	ACTIVE	SO	NS	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD14538B	Samples
CD14538BPWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM538B	Samples
CD14538BPWRG4	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM538B	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



#### **PACKAGE OPTION ADDENDUM**

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(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### PACKAGE MATERIALS INFORMATION

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#### TAPE AND REEL INFORMATION



# TAPE DIMENSIONS + K0 - P1 - B0 W Cavity - A0 -

A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD14538BM96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD14538BNSR	so	NS	16	2000	330.0	16.4	8.45	10.55	2.5	12.0	16.2	Q1
CD14538BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD14538BM96	SOIC	D	16	2500	340.5	336.1	32.0
CD14538BNSR	SO	NS	16	2000	356.0	356.0	35.0
CD14538BPWR	TSSOP	PW	16	2000	356.0	356.0	35.0

#### **PACKAGE MATERIALS INFORMATION**

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#### **TUBE**

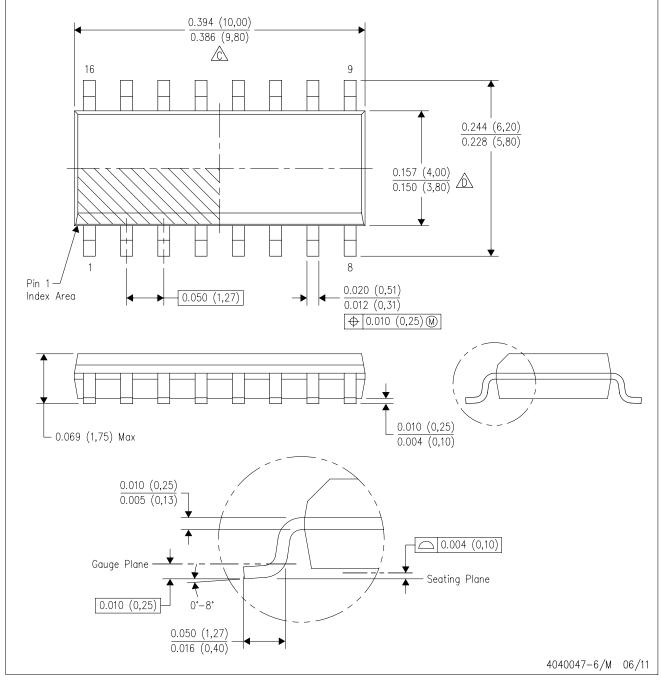


#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD14538BE	N	PDIP	16	25	506	13.97	11230	4.32
CD14538BE	N	PDIP	16	25	506	13.97	11230	4.32

#### D (R-PDSO-G16)

#### PLASTIC SMALL OUTLINE

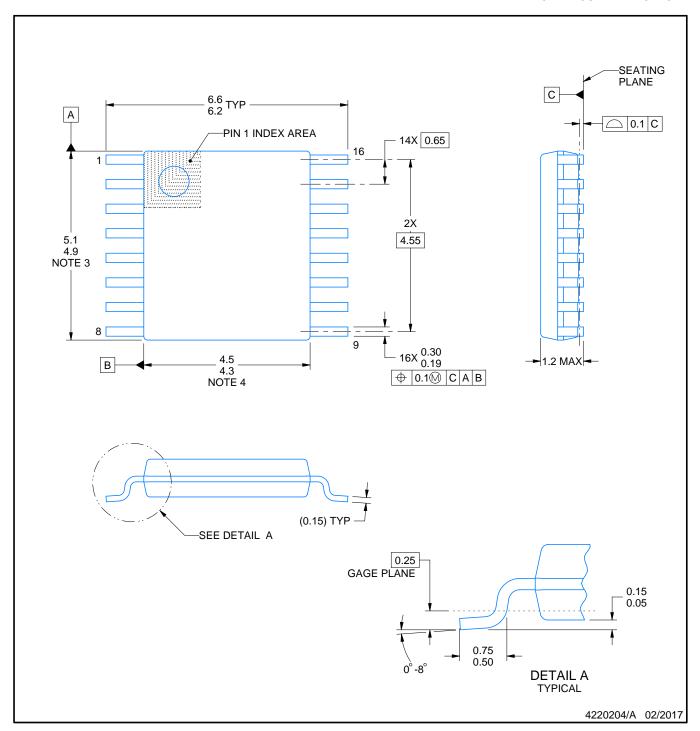


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.





SMALL OUTLINE PACKAGE



- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



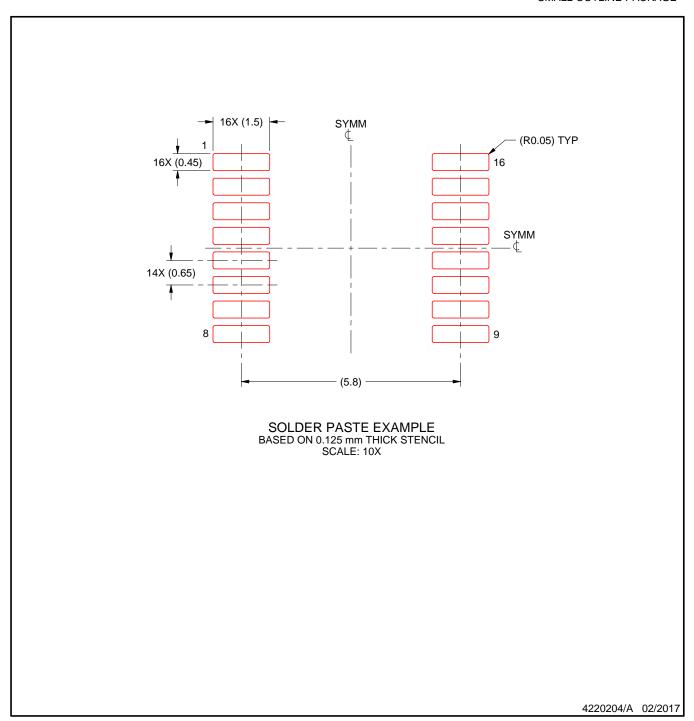
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



#### **MECHANICAL DATA**

#### NS (R-PDSO-G\*\*)

#### 14-PINS SHOWN

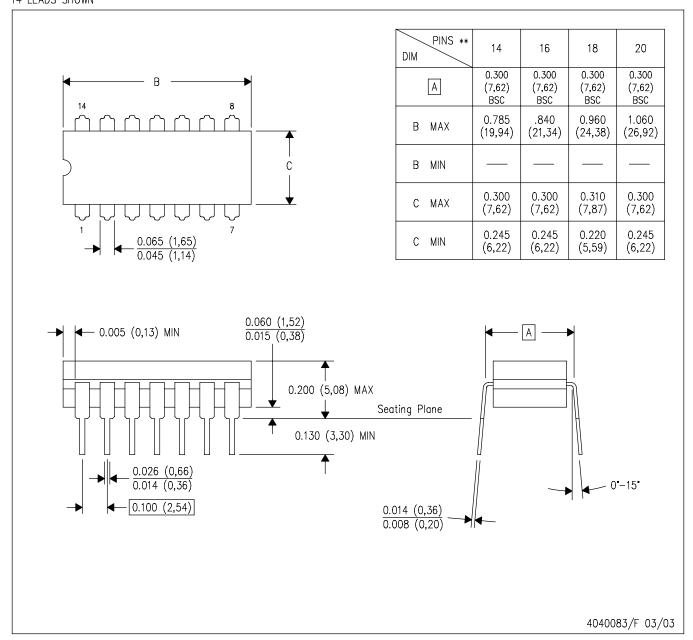
#### PLASTIC SMALL-OUTLINE PACKAGE



- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



#### 14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

#### N (R-PDIP-T\*\*)

#### PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN

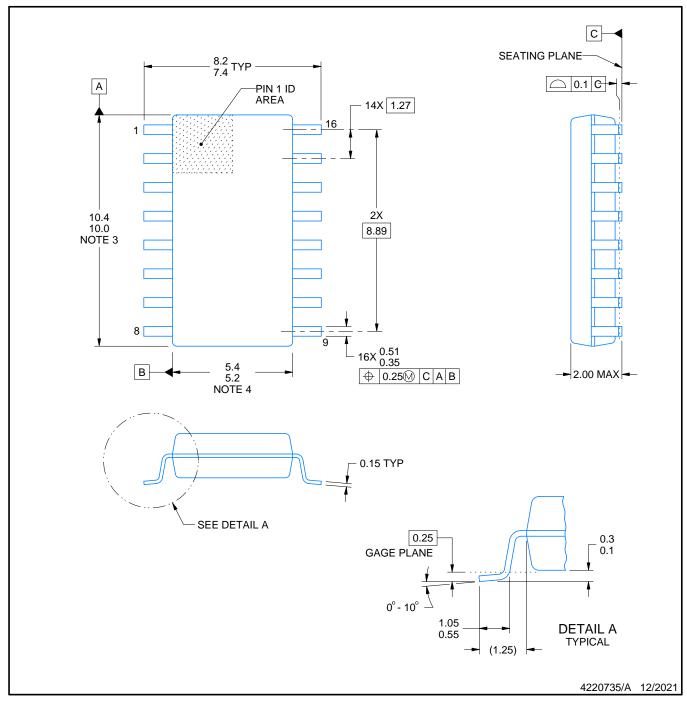


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





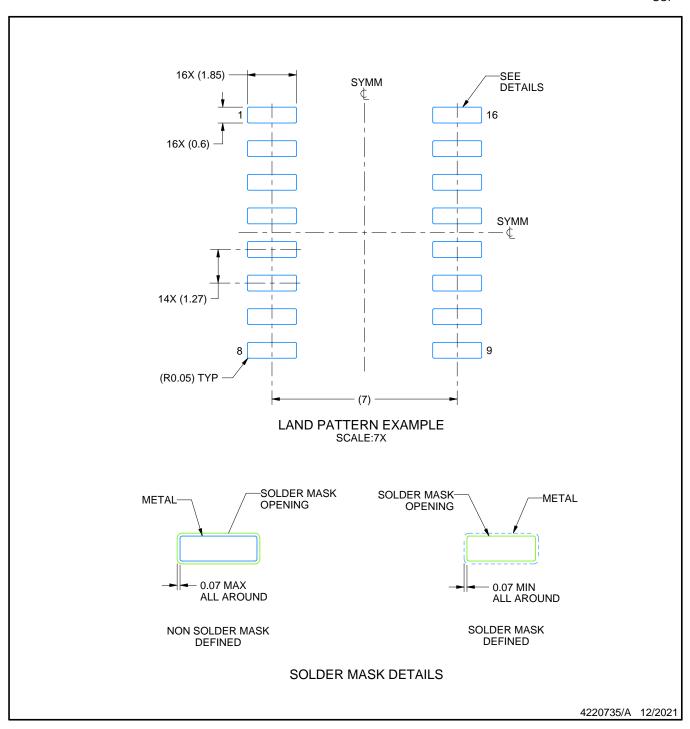
SOP



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm, per side.

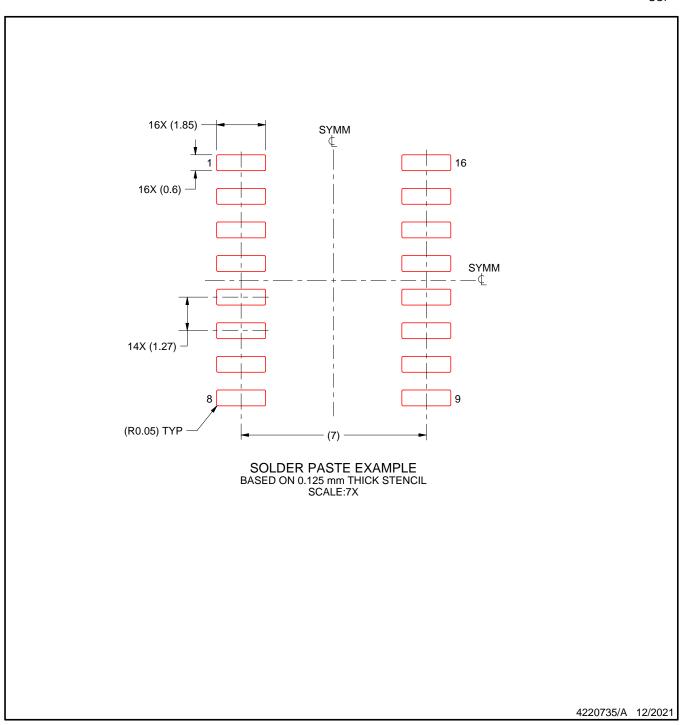
SOF



#### NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

SOF



#### NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



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